$_{\scriptscriptstyle 1}$ Transport properties of cubic zero-moment ferromagnetic $\mathsf{Mn_2Ru}_x\mathsf{Ga}$ thin $_{\scriptscriptstyle 2}$ films

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The spin-dependent transport properties of cubic $\mathrm{Mn_2Ru_xGa}$ thin-films are studied as a function of the the Ru concentration, x and the substrate induced strain. We find that at Ru concentration $x\approx 0.7$, which shows practically zero magnetization, the spontaneous Hall effect at room temperature reverses sign and the spontaneous Hall angle is maximized. In addition, a small tetragonal distortion, $c/a \sim 2\%$, allows us to tune the compensation of the two Mn sub-lattices to a preferred temperature at, above or below room temperature. Having two handles on the zero moment half magnetic properties of $\mathrm{Mn_2Ru_xGa}$ opens up the possibilities for using this new class of material in various spintronic devices. We also present the initial work on magnetoresistive devices based on pseudo-spin-valves with $\mathrm{Mn_2Ru_xGa}$ electrodes.

8 I. INTRODUCTION

Cubic ferromagnetic Heusler compounds are a family 10 of magnetic materials that often exhibit higher spin po- $_{11}$ larization at the Fermi level than binary ferromagnetic 3d₁₂ alloys¹. Some of the materials are half-metals with a gap 13 in the spin-polarized density of states for one spin band 14 which should make them ideal candidates for spin-valves ₁₅ or MTJs^{2–5}. Since the prediction by van Leuken and de Groot in 1995, of a half-metallic material with two in-17 equivalent magnetic sub-lattices whose moments cancel 18 out⁶, researchers have worked on fabricating such a ma-19 terial. While electronic structure calculations predicted 20 several such compounds⁷⁻⁹, fabrication of such materials had failed^{8,10}. In 2014, Kurt et. al. reported the growth of thin films of Mn₂Ru_xGa, which was identified 23 as a zero-moment ferrimagnet with high spin polarization and showed evidence of half-metallicity¹¹.

Here we report on the temperature, composition and thickness dependent transport properties of $\rm Mn_2Ru_xGa_{27}$ (MRG), which are at or near compensation point (0.6 < 28 x < 1.1). Addition of Ru to the cubic Mn2Ga structure provides both states (12) and electrons (8). Based on the on the empirical Slater-Pauling rules, should result in perfect compensation for $\rm Mn_2Ru_0 \cdot 5~Ga$. However the addition of Ru is likely to change both the shape and position of the Mn bands leading to a more transport properties. In addition the the tetragonal distortion (c/a) can also affect the band structure, hence we also look at strain as a possible control parameter in engineering the $\rm Mn_2Ru_xGa$ fully compensated half metallic system.

40 II. EXPERIMENTAL TECHNIQUES

MRG films of thickness 4 nm to 70 nm were grown 42 on MgO (001) substrates by dc-magnetron sputtering 43 at 250 °C substrate temperature and base pressure

 $_{44}$ 2 × 10⁻⁸ Torr in a Shamrock deposition system. The 45 films were co-sputtered from a Mn2Ga target and 46 Ru target, and the Ru composition was controlled by 47 keeping the Mn₂Ga sputtering power fixed while varying 48 that of Ru. The MRG films were capped with a $\sim 2\,\mathrm{nm}$ ⁴⁹ Al₂O₃ layer to prevent oxidation. The crystal structure ₅₀ and lattice parameters were determined by $2\theta - \theta$ and 51 reciprocal space map (RSM) scans using a BRUKER 52 D8 diffractometer with a $Cu - K\alpha$ source. In order to $_{53}$ determine the Ru concentration x, we deposited four 54 samples with varying Mn₂Ga target power along with a 55 Ru film. The density and thickness of the samples were then measured using x-ray reflectivity. Based on the 57 measured density and lattice parameters of these 5 con-58 trol samples, we establish a relation between the x-ray 59 density and the Ru concentration x against which all the 60 samples are calibrated. Magnetization measurements 61 were made using a Quantum Design superconducting 62 quantum interference device (SQUID) magnetome-The transport measurements were conducted 64 on unpatterned MRG films in a physical properties 65 measurement system (PPMS) for temperatures from 66 10 K to 400 K. The maximum applied magnetic fields, ₆₇ $\mu_0 H$, for the two systems were 5 T and 14 T respectively. 68 A summary of sample properties is provided in Table 69 I. We also incorporated the MRG as the hard layer 70 into a pseudo-spin-valve with the structure, MgO/ 71 $Mn_2Ru_xGa(15)/Cu(2.8)/[Co(0.2)/Pd(0.6)]_6/Ta(3 nm)$ 72 in order to investigate the spin dependent transport. 73 The MRG layer was grown at 250 °C, then cooled down 74 to room temperature, and was subsequently transferred 75 to a different deposition chamber for the Cu/[Co/Pd] 76 multilayer deposition. Atomic force microscopy mea-77 surements of the MRG film showed a roughness of $_{78} \sim 0.2 \, \mathrm{nm}$, free of pinholes.

TABLE I. Summary of sample properties. The temperature at which full compensation occurs, T_{comp} was defined by the temperature where $\partial \rho_{xy}/\partial T$ reaches its maximum.

Ru x	t	c/a-1	M_s	T_{comp}
	$_{ m nm}$	%	$\mu_{ m B}$	K
0.62	70	2.07	-0.09	100-200
0.69	70	1.76	0.03	200-300
0.73	70	1.83	0.07	300-360
0.77	70	1.92	0.09	> 360
1.09	70	1.82	0.07	> 360
1.12	70	1.84	-	387
1.01	34	1.92	-	335
0.98	16	2.24	-	280
1.09	8	2.90	-	214
1.07	4	3.60	-	< 10

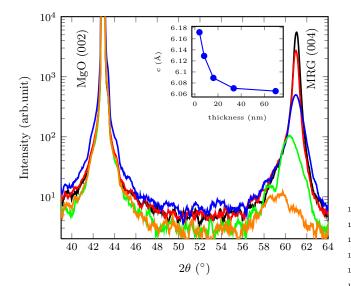


FIG. 1. XRD of thin films of Mn_2Ru_xGa of thickness from $70\,\mathrm{nm}$ to $4\,\mathrm{nm}$ grown on MgO substrates. Inset shows the strain is increasingly relaxed as the thickness increases.

RESULTS AND DISCUSSION

81 different thickness and compositions were probed us- 116 for amorphous rare earth transition metal alloys 13. A $_{82}$ ing $2\theta-\theta$ x-ray diffraction (XRD) as shown in Fig. $_{117}$ high spontaneous Hall angle is indicative of much lower 1. The out-of-plane lattice parameter, c, is between 118 carrier concentrations and a high spin polarization. 84 0.598 nm and 0.618 nm, depending on the Ru concen- 119 As shown in Fig. 1, the MRG films are increas-85 tration and film thickness (insert of Fig. 1). The in- 120 ingly strained as the thickness of the film is reduced. It ₈₆ plane lattice parameter, a, determined from reciprocal ₁₂₁ has been predicted that the magnetization may depend 87 space maps was found to be 0.596 nm for all samples, 122 strongly on the lattice distortion since this would have plane distortion (c/a - 1) between 1.8% and 3.6%).

94 the magnetic sub-lattices. Clear out-of-plane anisotropy 129 can be seen that the coercivity diverges to 29 T at 350 K with a large coercivity of 1.2 T is evident. A small soft 130 and the sign of the SHE loop reverses at 300 K. This in-

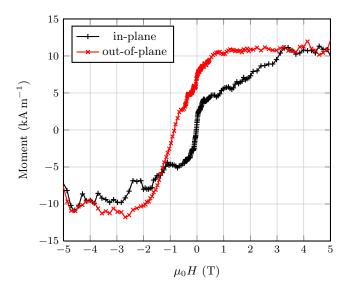


FIG. 2. In-plane and out-of-plane magnetization loops of Mn₂Ru_xGa sample of thickness 70 nm, measured in a SQUID magnetometer at 300 K.

97 centration is reduced from x = 1.09, the magnetization ₉₈ reduces, until it falls practically to zero (12 kA m⁻¹ or 99 $0.07 \,\mu_{\rm B} \,{\rm f.u.^{-1}}$) at x = 0.68 as shown in Fig. 4(a). We 100 can attribute this to the almost perfect compensation of the two Mn sub-lattices at room temperature. On further reduction of Ru the magnetization again increases. We 103 denote this as a negative magnetization, coincident with 104 the reversal in sign in the room temperature spontaneous 105 Hall effect (SHE) measurements as shown in Fig. 3(a). 106 From the SHE measurements with varying Ru content, we extracted the coercivity, $\mu_0 H_c$, and spontaneous Hall dependence of the out-of-plane lattice parameter (c) on the 108 angle (SHA) (defined as ρ_H/ρ) (Fig. 4(b)). As the magthickness of the film, indicating that the substrate induced 109 netization approaches zero the coercivity clearly diverges 110 (the sample closest to compensation at room tempera-111 ture could not be saturated at an applied field of 5 T). 112 The recorded spontaneous Hall angles for samples near compensation ($\sim 5\%$) are about a magnitude larger than 114 those reported for other 3d ferromagnets at room temper-The crystal structure of the cubic MRG films with 115 ature (0.2 to 0.3%)¹² and comparable to SHA recorded

which is precisely matched to that of the MgO substrate 123 an effect on the interaction between neighbouring atoms. $(\sqrt{2}a_0 \,(\mathrm{MgO}) = 0.5956 \,\mathrm{nm})$. This confirms the cubic na- 124 We prepared $\mathrm{Mn_2Ru_xGa}$ samples of different thickness ture of the MRG films with a slight tetragonal out-of- 125 from 70 nm down to 4 nm and measured their SHE re-126 sponse at different temperatures from 400 K to 4 K in the Fig. 2 shows the magnetization measurement at 300 K 127 PPMS. Fig. 3(b) shows a typical SHE response over the of a typical MRG film of 70 nm near compensation of 128 temperature range for the sample of 34 nm thickness. It ₉₆ in-plane component is also clearly visible. As the Ru con- ₁₃₁ dicates that the compensation temperature lies between

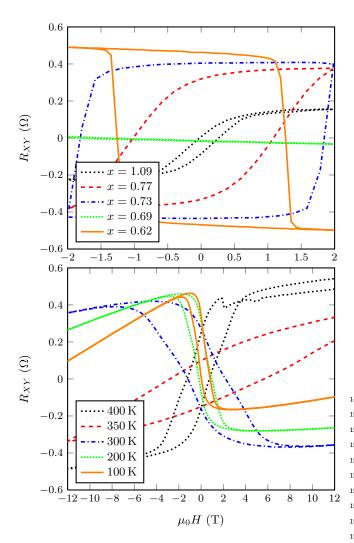


FIG. 3. SHE loops measured of Mn₂Ru_xGa for (a) various Ru compositions (0.6 < x < 1.1) and (b) temperatures between 10 K to 400 K, which illustrates the change of sign of the spon-300 K to 350 K respectively.

132 300 K to 350 K. By plotting the derivative of the Hall re-133 sistance w.r.t temperature, $\delta R_{XY}/\delta T$, as shown in Fig. 5(a), it can be seen that this compensation temperature 168 the electronic transport (Fig. 3, and 6). shifts to lower temperatures as the thickness of the MRG is reduced. It is worth noting that the compensation temperature varies with both the Ru content and strain. 169 IV. CONCLUSION Since the compensation is achieved by the cancelling out 139 of the moment of the two inequivalent Mn sub-lattices, 170 the extracted coercivity and SHA show maximum values shown in Fig. 5(b) and (c) respectively.

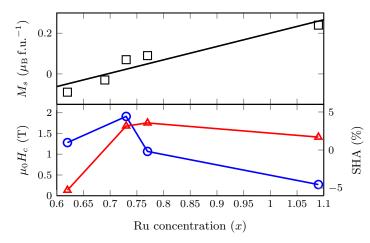


FIG. 4. (a) Extracted magnetization at 300 K (in $\mu_{\rm B}$ f.u.⁻¹), for samples of thickness 70 nm with different Ru composition (0.6 < x < 1.1). The change of sign of the magnetization was established by SHE sign reversal at compensation. (b) Coercive field and spontaneous Hall angle as a function of Ru composition, extracted from SHE measurements carried out at 300 K, for the same MRG samples as in (a).

on unpatterned films in the current-in-plane configura-150 tion. A MR effect was cleared observed at 2 K, and per-151 sists even at room temperature as shown in Fig. 6. The observed MR is however quite low (~ 0.15) even at 4 K 153 which may be due to two effects: Firstly considering the 154 transfer between separate deposition chambers for the 155 MRG and Cu/[Co/Pd] layers, some interfacial contamination or oxidation of the Mn can be expected. Secondly, 157 based on the results shown for the thickness dependence of the MRG films, as discussed above, we find that the films are increasingly strained as the thickness of the film is reduced. This causes a variation in the spin-dependent transport properties and compensation of the two magtaneous hall coefficient between x = 0.62 and x = 0.73 and $_{162}$ netic sub lattices, compared to the thicker films. Fur-163 thermore we assume that magnetic domains are present in the MRG film as in antiferromagnets; GMR is lost rel-165 atively quickly due to domain structuring and imperfect 166 rotation of the magnetisation in the two electrodes, as 167 evidenced by dispersed switching field range as shown in

We have shown above that the spin-dependent transthis shift in compensation temperature may be due to $_{\mbox{\tiny 171}}$ port properties of $\mbox{Mn}_2\mbox{Ru}_x\mbox{Ga}$ are tuneable with both the slightly different temperature dependence of the two $\frac{1}{172}$ the Ru concentration x and strain. Recent ab inito sub-lattices. As with samples with different Ru content, $_{173}$ calculations 14 while providing some insight into the electrons. 174 tronic structure, does not give convincing arguments exnear the compensation temperature for each thickness as $_{175}$ plaining the variation of the transport properties both with varying Ru concentration x and strain. Above we Finally we measured the magnetoresistance (MR) 177 have shown that for a Ru concentration $x \approx 0.7$, which properties of the MRG/Cu/[Co/Pd] samples at different 178 shows practically zero magnetization, the sign of the 148 temperatures from 2 K to 300 K. The MR was measured 179 spontaneous Hall effect is reversed, indicating the rever-

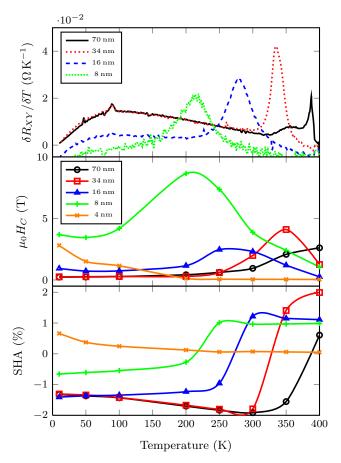
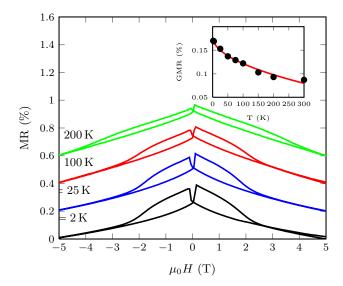


FIG. 5. (a) Variation of compensation temperature with the thickness of MRG film of same Ru concentration, given by the derivative of the resistance w.r.t temperature. The compensation temperature shifts to lower temperatures with decreasing thickness. (b) Extracted coercive field and (c) spontaneous Hall angle as a function of temperature for samples with the same Ru concentration ($x \sim 1.0$) and various thickness from $70\,\mathrm{nm}$ to $4\,\mathrm{nm}$.

180 sal of the majority spin channel. Concurrently the the 181 spontaneous Hall angle is maximised which would imply 182 a reduction in the carrier concentration and high spin 214 polarisation that point towards a half metallic state. We 215 also show that by varying the tetragonal distortion at 216 a particular Ru composition, we can tune the compensation of the two Mn sub lattices to be at a relavant $\frac{1}{219}$ 10 E. Şaşıoğlu, Phys. Rev. B **79**, 100406 (2009). temperature regime at above or below room tempera- 220 ture. The initial demonstration of magnetoresistance 221 in pseudo-spin-valves with an MRG electrode indicates that while we are able to observe a MR effect, further understanding of the magnetic domain and micromagnetic structures are necessary for improving device per-193 formance.



MRofa. pseudo valve $Mn_2Ru_xGa(15)/Cu(2.8)/[Co(0.2)/Pd(0.6)]_6/Ta(3 nm)$ measured at various temperatures. The curves have been offset vertically for clarity. The inset shows the temperature variation of the GMR contribution with a fit to $T^{0.5}$ dependence.

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